


<b>Search Notes</b>  	<b>Application/Control No.</b>  110579278	<b>Applicant(s)/Patent Under Reexamination</b>  LAPPE, KURT
	<b>Examiner</b>  Yuan L Chen	<b>Art Unit</b>  2854

SEARCHED			
Class	Subclass	Date	Examiner
101	23, 32, 232, 492	11/18/2009	LTH

SEARCH NOTES		
Search Notes	Date	Examiner
limited classification (101/32, 101/232) search	3/13/2009	yc
text search (seesearch history)	3/12,13,18/2009	yc
Inventor name search, keyword search	11/18/2009	LTH
Review ISR from parent PCT/EP04/12676	11/18/2009	LTH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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